IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

McARTHUR, et al.

Serial No.:

10/039,426

Conf. No.:

8965

Filed:

January 4, 2002

For:

METHOD AND APPARATUS FOR

PROPER ORDERING OF REGISTRATION DATA

Art Unit:

2851

Examiner:

Unassigned

I hereby certify that this paper and the attached papers are being deposited with the United States Postal Service as first class mail in an envelope addressed to:

Commissioner for Patents
US Patent and Trademark Office
PO Box 2327

Arlington, VA 22202, on this date.

4V02

Michelle Melon

Date

ate Michelle Melender

PRELIMINARY AMENDMENT

Commissioner for Patents US Patent and Trademark Office PO Box 2327 Arlington, VA 22202

Dear Sir:

Preliminary to examination of the above-captioned patent application, please amend the specification as follows:

IN THE SPECIFICATION:

Please amend the specification as follows (a marked up copy of the amended specification is attached to this Amendment):

Please replace the paragraph at page 3, lines 3-19, with the following:

Figure 5(a) shows a typical overlay displacement vector 502 representing the x-shift and y-shift vector overlay error associated with a misaligned frame-in-frame alignment attribute. In some cases the overlay error can be measured using special in-situ exposure tool metrology See Direct-referencing automatic two-points reticle-to-wafer alignment using a projection column servo system, *supra*. Many

to Enter Jung